International Rectifier

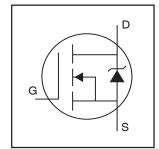
HEXFET® Power MOSFET

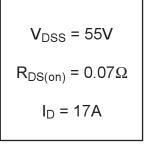
- Advanced Process Technology
- Dynamic dv/dt Rating
- 175°C Operating Temperature
- Fast Switching
- Fully Avalanche Rated
- Lead-Free

Description

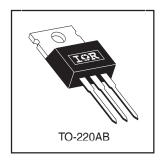
Fifth Generation HEXFET® power MOSFETs from International Rectifier utilize advanced processing techniques to achieve the lowest possible on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET power MOSFETs are well known for, provides the designer with an extremely efficient device for use in a wide variety of applications.

The TO-220 package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 watts. The low thermal resistance and low package cost of the TO-220 contribute to its wide acceptance throughout the industry.





IRFZ24NPbF



Absolute Maximum Ratings

	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V	17	
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V	12	A
I _{DM}	Pulsed Drain Current	68	
P _D @T _C = 25°C	Power Dissipation	45	W
	Linear Derating Factor	0.30	W/°C
V_{GS}	Gate-to-Source Voltage	±20	V
E _{AS}	Single Pulse Avalanche Energy ②	71	mJ
I _{AR}	Avalanche Current①	10	A
E _{AR}	Repetitive Avalanche Energy①	4.5	mJ
dv/dt	Peak Diode Recovery dv/dt ③	5.0	V/ns
TJ	Operating Junction and	-55 to + 175	
T _{STG}	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)	
	Mounting torque, 6-32 or M3 screw.	10 lbf•in (1.1N•m)	

Thermal Resistance

	Parameter	Min.	Тур.	Max.	Units
$R_{\theta JC}$	Junction-to-Case			3.3	
$R_{\theta CS}$	Case-to-Sink, Flat, Greased Surface		0.50		°C/W
$R_{\theta JA}$	Junction-to-Ambient			62]

IRFZ24NPbF

International
Rectifier

Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	55			V	V _{GS} = 0V, I _D = 250µA
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient		0.052		V/°C	Reference to 25°C, I _D = 1mA
R _{DS(on)}	Static Drain-to-Source On-Resistance			0.07	Ω	V _{GS} = 10V, I _D = 10A ④
V _{GS(th)}	Gate Threshold Voltage	2.0		4.0	V	$V_{DS} = V_{GS}, I_D = 250 \mu A$
g _{fs}	Forward Transconductance	4.5			S	V _{DS} = 25V, I _D = 10A
	Drain-to-Source Leakage Current			25		V _{DS} = 55V, V _{GS} = 0V
I _{DSS}				250	μA	V _{DS} = 44V, V _{GS} = 0V, T _J = 150°C
	Gate-to-Source Forward Leakage			100		V _{GS} = 20V
I _{GSS}	Gate-to-Source Reverse Leakage			-100	nA	V _{GS} = -20V
Q _a	Total Gate Charge			20		I _D = 10A
Q _{gs}	Gate-to-Source Charge			5.3	nC	V _{DS} = 44V
Q _{gd}	Gate-to-Drain ("Miller") Charge			7.6		V _{GS} = 10V, See Fig. 6 and 13 ⊕
t _{d(on)}	Turn-On Delay Time		4.9			V _{DD} = 28V
t _r	Rise Time		34			I _D = 10A
t _{d(off)}	Turn-Off Delay Time		19		ns	$R_G = 24\Omega$
t _f	Fall Time		27			R _D = 2.6Ω, See Fig. 10 ④
LD	Internal Drain Inductance		4.5		Between lead,	
L _D	Internal Drain Inductance				nН	6mm (0.25in.)
	Internal Source Inductance		7.5			from package
L _S						and center of die contact
C _{iss}	Input Capacitance		370			V _{GS} = 0V
C _{oss}	Output Capacitance		140		pF	$V_{DS} = 25V$
C _{rss}	Reverse Transfer Capacitance		65			f = 1.0MHz, See Fig. 5

Source-Drain Ratings and Characteristics

	Parameter	Min.	Тур.	Max.	Units	Conditions						
Is	Continuous Source Current			17		MOSFET symbol						
	(Body Diode)			17	A	showing the						
I _{SM}	Pulsed Source Current			68	, ,	integral reverse						
	(Body Diode) ①							_ 00	00	00	00	
V _{SD}	Diode Forward Voltage			1.3	V	T _J = 25°C, I _S = 10A, V _{GS} = 0V ④						
t _{rr}	Reverse Recovery Time		56	83	ns	$T_J = 25^{\circ}C, I_F = 10A$						
Q _{rr}	Reverse RecoveryCharge		120	180	nC	di/dt = 100A/μs ④						

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- $^{\odot}$ V_{DD} = 25V, starting T_J = 25°C, L = 1.0mH R_G = 25 $^{\circ}$ C, I_{AS} = 10A. (See Figure 12)
- $\begin{tabular}{l} \begin{tabular}{l} \begin{tab$
- ④ Pulse width \leq 300 μ s; duty cycle \leq 2%.

International TOR Rectifier

IRFZ24NPbF

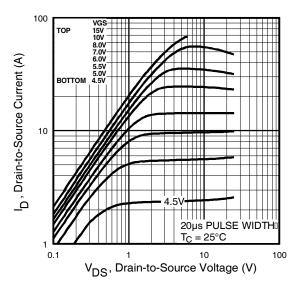


Fig 1. Typical Output Characteristics, $T_J = 25^{\circ}C$

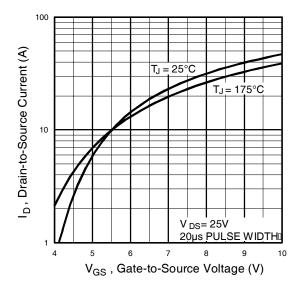


Fig 3. Typical Transfer Characteristics

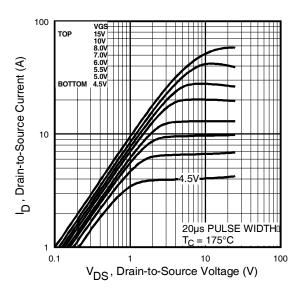


Fig 2. Typical Output Characteristics, $T_J = 175$ °C

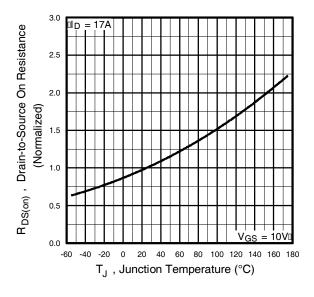


Fig 4. Normalized On-Resistance Vs. Temperature

IRFZ24NPbF

International TOR Rectifier

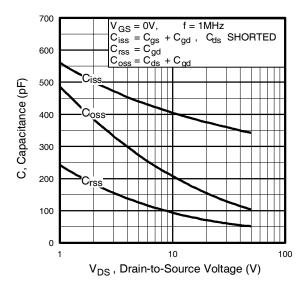


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

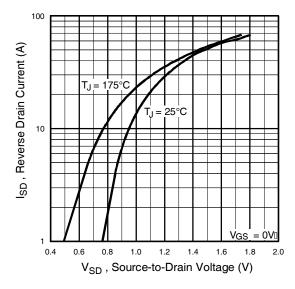


Fig 7. Typical Source-Drain Diode Forward Voltage

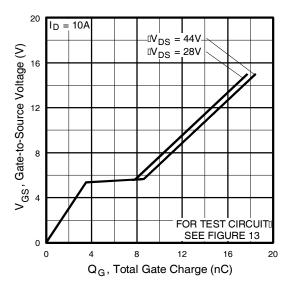


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

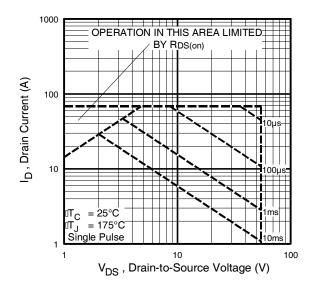


Fig 8. Maximum Safe Operating Area

International TOR Rectifier

IRFZ24NPbF

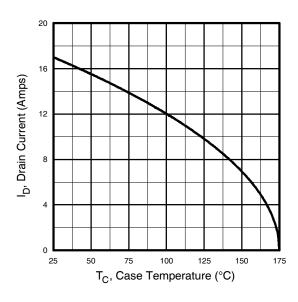


Fig 10a. Switching Time Test Circuit

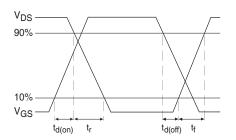


Fig 9. Maximum Drain Current Vs.
Case Temperature

Fig 10b. Switching Time Waveforms

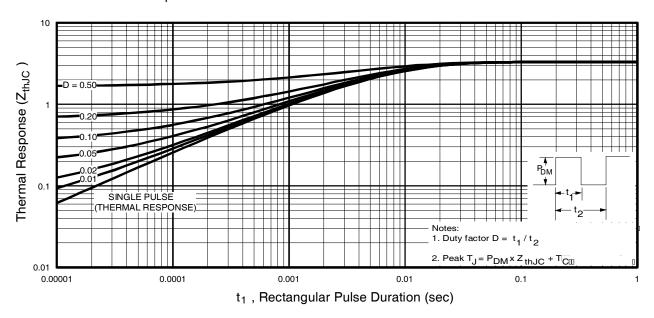


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

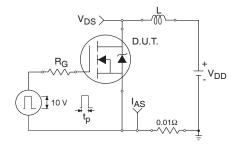


Fig 12a. Unclamped Inductive Test Circuit

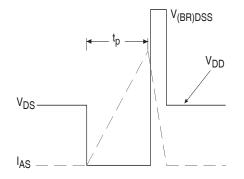


Fig 12b. Unclamped Inductive Waveforms

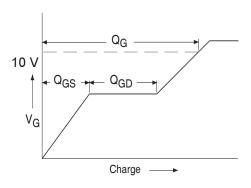


Fig 13a. Basic Gate Charge Waveform

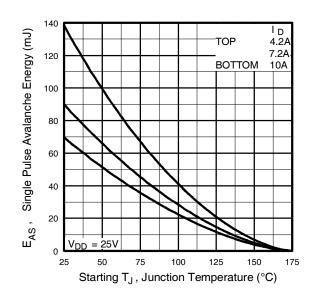


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

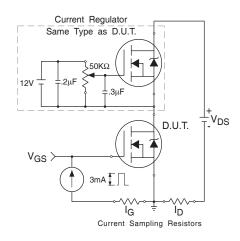
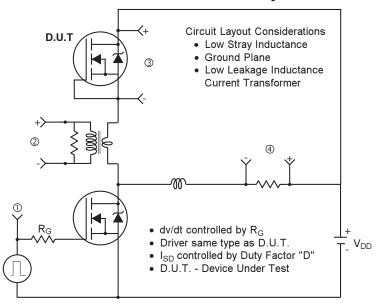
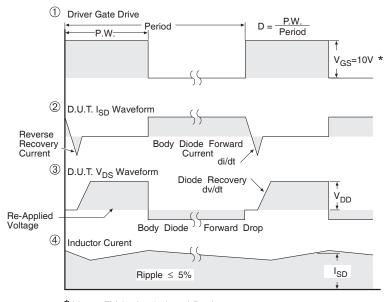


Fig 13b. Gate Charge Test Circuit

IRFZ24NPbF

Peak Diode Recovery dv/dt Test Circuit



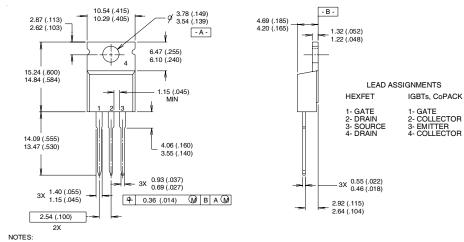


* V_{GS} = 5V for Logic Level Devices

Fig 14. For N-Channel HEXFET® power MOSFETs

TO-220AB Package Outline

Dimensions are shown in millimeters (inches)



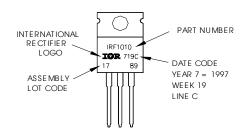
- 1 DIMENSIONING & TOLERANCING PER ANSI Y14.5M, 1982
 - 2 CONTROLLING DIMENSION : INCH
- 3 OUTLINE CONFORMS TO JEDEC OUTLINE TO-220AB.
- 4 HEATSINK & LEAD MEASUREMENTS DO NOT INCLUDE BURBS

TO-220AB Part Marking Information

EXAMPLE: THIS IS AN IRF1010 LOT CODE 1789

ASSEMBLED ON WW 19, 1997 IN THE ASSEMBLY LINE "C"

Note: "P" in assembly line position indicates "Lead-Free"



Data and specifications subject to change without notice.



IR WORLD HEADQUARTERS: 233 Kansas St., El Segundo, California 90245, USA Tel: (310) 252-7105

TAC Fax: (310) 252-7903

Visit us at www.irf.com for sales contact information.02/04

Note: For the most current drawings please refer to the IR website at: http://www.irf.com/package/

IMPORTANT NOTICE

The information given in this document shall in no event be regarded as a guarantee of conditions or characteristics ("Beschaffenheitsgarantie").

With respect to any examples, hints or any typical values stated herein and/or any information regarding the application of the product, Infineon Technologies hereby disclaims any and all warranties and liabilities of any kind, including without limitation warranties of non-infringement of intellectual property rights of any third party.

In addition, any information given in this document is subject to customer's compliance with its obligations stated in this document and any applicable legal requirements, norms and standards concerning customer's products and any use of the product of Infineon Technologies in customer's applications.

The data contained in this document is exclusively intended for technically trained staff. It is the responsibility of customer's technical departments to evaluate the suitability of the product for the intended application and the completeness of the product information given in this document with respect to such application.

For further information on the product, technology, delivery terms and conditions and prices please contact your nearest Infineon Technologies office (www.infineon.com).

WARNINGS

Due to technical requirements products may contain dangerous substances. For information on the types in question please contact your nearest Infineon Technologies office.

Except as otherwise explicitly approved by Infineon Technologies in a written document signed by authorized representatives of Infineon Technologies, Infineon Technologies' products may not be used in any applications where a failure of the product or any consequences of the use thereof can reasonably be expected to result in personal injury.